

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/663,249	CHEN ET AL.	
Examiner		Art Unit		Page 1 of 1
Richard Hanig		2873		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0030125	02-2004	Li et al.	540/126
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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